1200 V, 50 A Fast Field-Stop IGBT 7

APT50GH120B

Product Overview

1200 V, 50 A Fast Field-Stop IGBT, TO-247

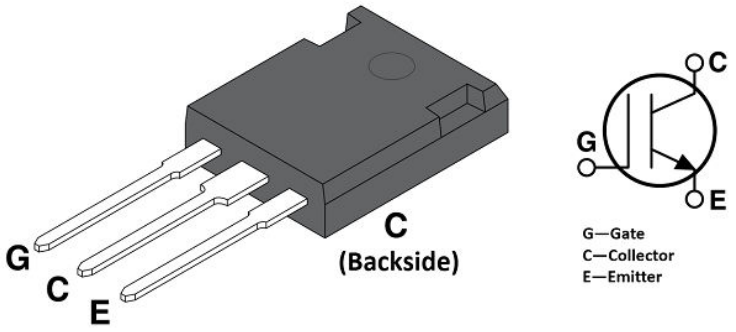


Table 1. Ordering Information

Catalog Part Number (CPN)	Package	Packing Media	Qualification
APT50GH120B	TO-247	Tube	Industrial

Features

- Low conduction loss and saturation voltage
- Fast switching
- Low gate charge
- Ultrafast tail current shutoff
- Reverse-bias safe operating area (RBSOA) rated
- Easy to parallel
- RoHS compliant

1. Device Specifications: IGBT

This section shows the specifications of this device.

1.1. Absolute Maximum Ratings

The following table shows the absolute maximum ratings of this device. T_C = 25 °C unless otherwise specified.

Table 1-1. Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
V_{CES}	Collector-emitter voltage	1200	V
V_{GE}	Gate-emitter voltage	±20	
I_{C1}	Continuous collector current[1] (T_C = 25 °C)	119	A
I_{C2}	Continuous collector current[1] (T_C = 100 °C)	73	
I_{CM}	Pulsed collector current[2] (T_C = 175 °C)	200	
RBSOA	Reverse-bias safe operating area (T_J = 150 °C, 960 V)	200	A
P_D	Total power dissipation	492	W

Notes:

1. Limited by maximum lead temperature.
2. Repetitive rating: Pulse width and case temperature are limited by the maximum junction temperature.

1.2. Thermal and Mechanical Characteristics

The following table shows the thermal and mechanical characteristics of this device.

Table 1-2. Thermal and Mechanical Characteristics

Symbol	Characteristic	Min.	Typ.	Max.	Unit
$R_{\Theta JC}$	Junction-to-case thermal resistance (IGBT)		0.21	0.31	°C/W
T_J, T_{STG}	Operating and storage junction temperature	–40		175	°C
T_L	Lead temperature for 10 seconds			300	
τ_M	Mounting torque, M3 screw for heat sink attachment (requires 1, not included)		0.8		N·m
Wt	Package weight		6.2		g

1.3. Electrical Performance

The following table shows the static characteristics of this device. T_C = 25 °C unless otherwise specified.

Table 1-3. Static Characteristics

Symbol	Characteristic	Test Conditions	Min.	Typ.	Max.	Unit
$V_{GE(th)}$	Gate threshold voltage	V_{CE} = V_{GE}, I_C = 0.8 mA	4.7	5.5	6.2	V
$V_{CE(ON)}$	Collector-emitter on voltage	V_{GE} = 15 V, I_C = 50 A		1.7	2.15	
		V_{GE} = 15 V, I_C = 50 A, T_J = 175 °C		2.1		
I_{CES}	Collector cut-off current	V_{CE} = 1200 V, V_{GE} = 0 V			40	µA
		V_{CE} = 1200 V, V_{GE} = 0 V, T_J = 175 °C		3500		
I_{GES}	Gate-emitter leakage current	V_{GE} = ±20 V			±100	nA

The following table shows the dynamic characteristics of this device. T_C = 25 °C unless otherwise specified.

Table 1-4. Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min.	Typ.	Max.	Unit
C_{ies}	Input capacitance	V_{GE} = 0 V, V_{CE} = 25 V, f = 200 kHz		6885		pF
C_{res}	Reverse transfer capacitance			95		
C_{oes}	Output capacitance			36		
V_{GEP}	Gate-to-emitter plateau voltage	V_{GE} = 15 V, V_{CE} = 960 V, I_C = 50 A		7.5		V
Q_G	Total gate charge[1]			375		nC
Q_{GE}	Gate-emitter charge			46		
Q_{GC}	Gate-collector ("Miller") charge			143		
RBSOA	Reverse-bias safe operating area	T_J = 175 °C, R_G = 23 Ω, V_{GE} = 15 V, V_{CE} = 800 V, L = 100 µH	200			A
$t_{d(on)}$	Turn-on delay time	V_{CC} = 800 V, V_{GE} =15 V, I_C = 50 A, R_G = 5 Ω, T_J = 25 °C		22		ns
t_r	Current rise time			31		
$t_{d(off)}$	Turn-off delay time			222		
t_f	Current fall time			33		
E_{on}	Turn-on switching energy[2]			2220		µJ
E_{off}	Turn-off switching energy[3]			1470		
$t_{d(on)}$	Turn-on delay time	V_{CC} = 800 V, V_{GE} = 15 V, I_C = 50 A, R_G = 5 Ω, T_J = 175 °C		22		ns
t_r	Current rise time			31		
$t_{d(off)}$	Turn-off delay time			259		
t_f	Current fall time			51		
E_{on}	Turn-on switching energy[2]			2300		µJ
E_{off}	Turn-off switching energy[3]			2440		

Notes:

1. See MIL-STD-750 Method 3471.
2. E_{on} is the clamped inductive turn-on-energy of this device. (See Figure 1-19, Figure 1-20.)
3. E_{off} is the clamped inductive turn-off energy measured in accordance with JEDEC standard JESD24-1. (See Figure 1-19, Figure 1-21.)

1.4. Typical Performance Curves: IGBT

Data for performance curves are characterized, not 100% tested.

Figure 1-1. Output Characteristics

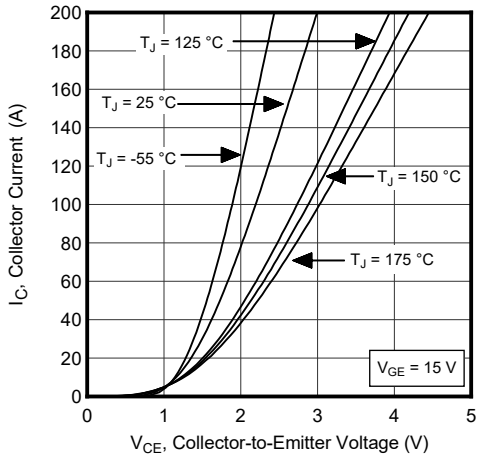


Figure 1-2. Transfer Characteristics

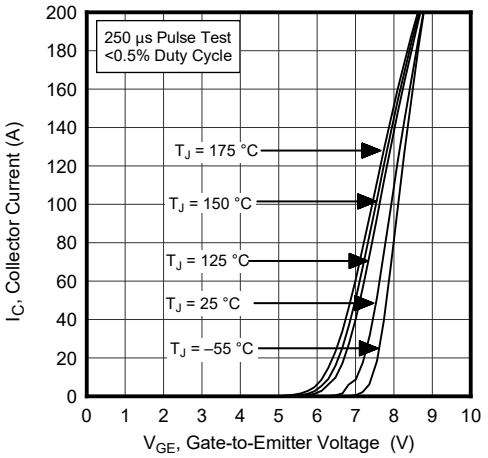


Figure 1-3. Gate Charge

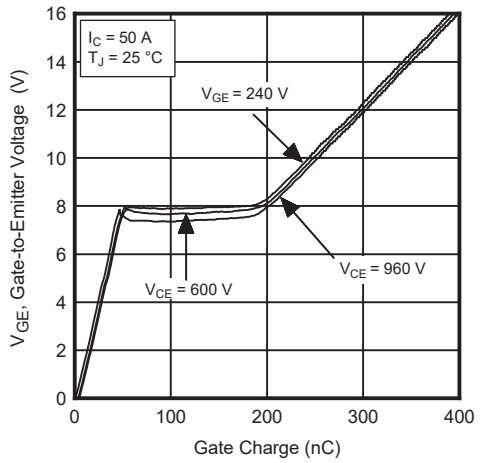


Figure 1-4. On-State Voltage vs. Gate-to-Emitter Voltage

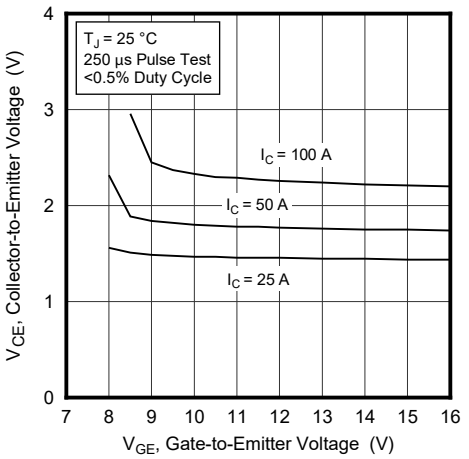


Figure 1-5. On-State Voltage vs. Junction Temperature

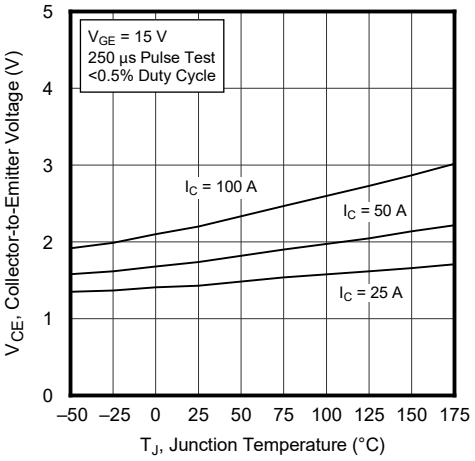


Figure 1-6. DC Collector Current vs. Case Temperature

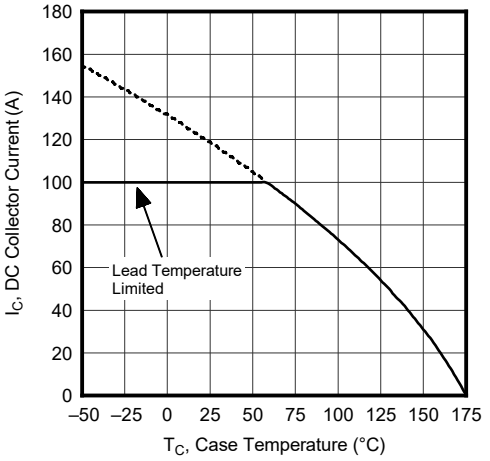


Figure 1-7. Turn-On Delay Time vs. Collector Current

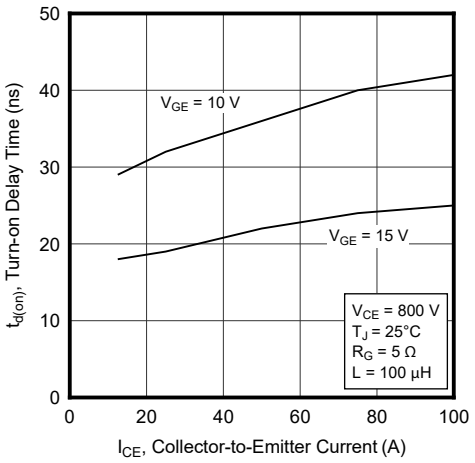


Figure 1-8. Turn-Off Delay Time vs. Collector Current

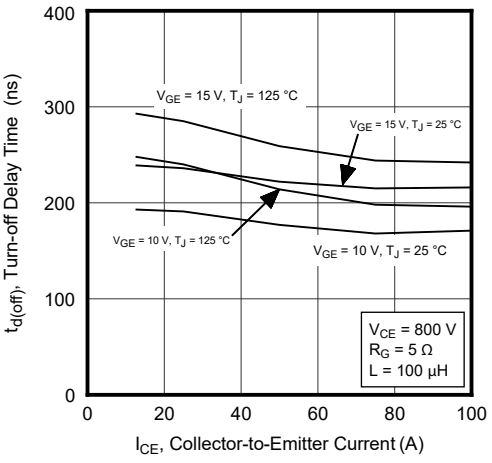


Figure 1-9. Current Rise Time vs. Collector Current

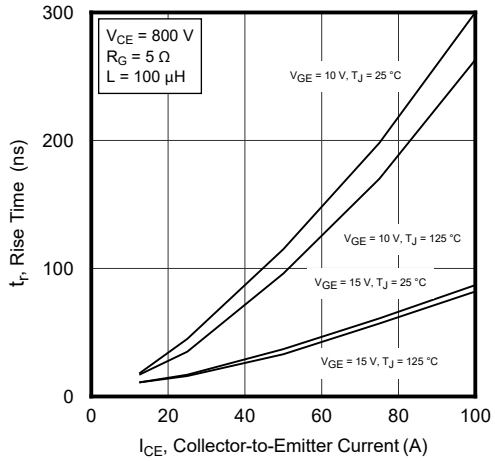


Figure 1-10. Current Fall Time vs. Collector Current

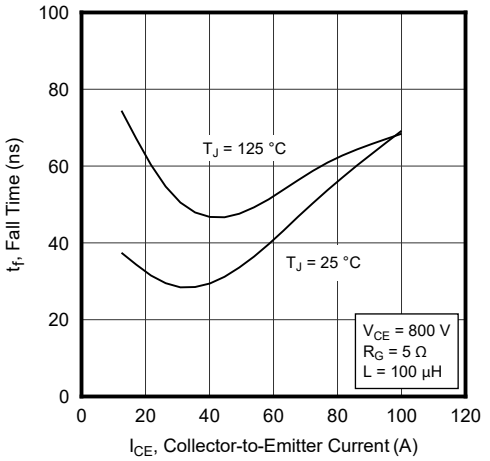


Figure 1-11. Turn-On Energy Loss vs. Collector Current

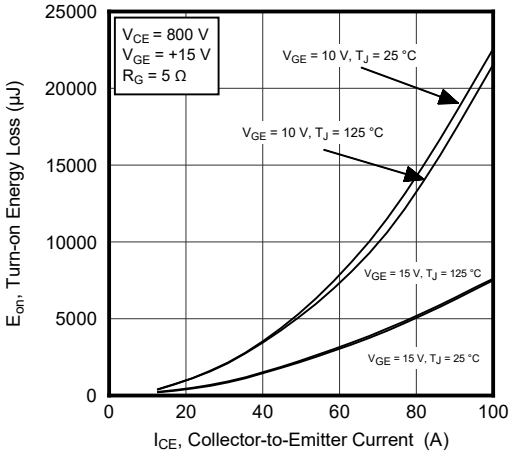


Figure 1-12. Turn-Off Energy Loss vs. Collector Current

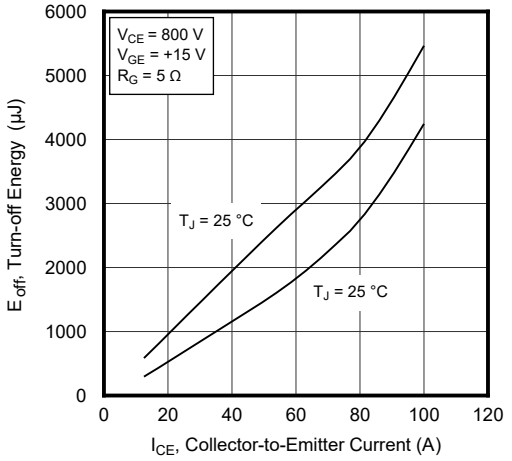


Figure 1-13. Switching Energy Losses vs. Gate Resistance

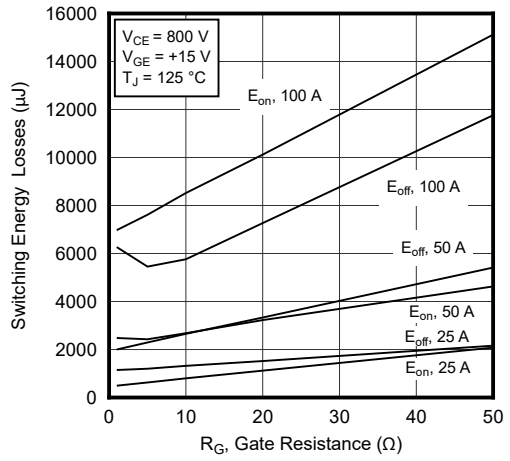


Figure 1-14. Switching Energy Losses vs. Junction Temperature

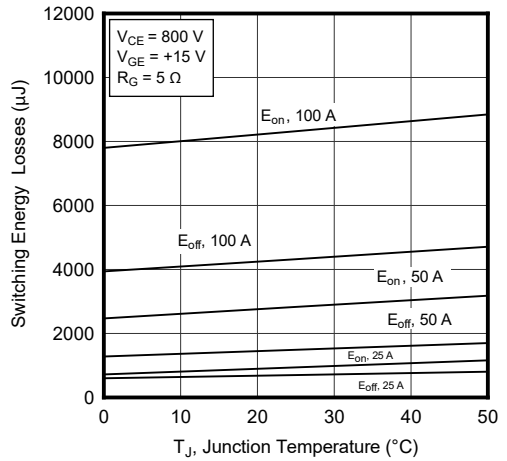


Figure 1-15. Capacitance vs. Collector-To-Emitter Voltage

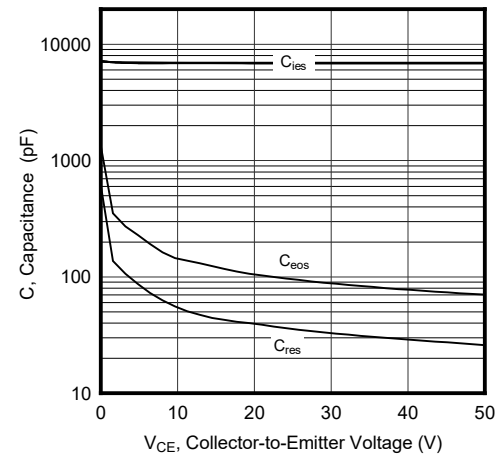


Figure 1-16. Reverse-bias Safe Operating Area

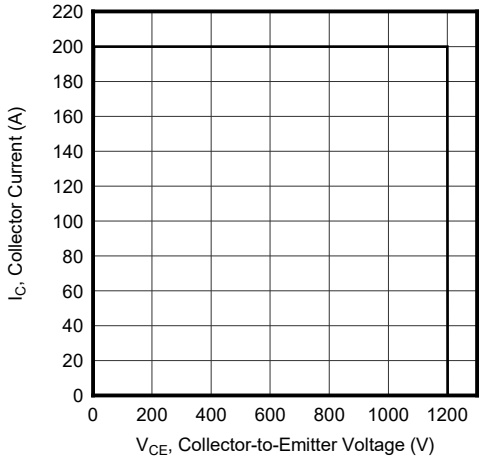


Figure 1-17. Maximum Transient Thermal Impedance

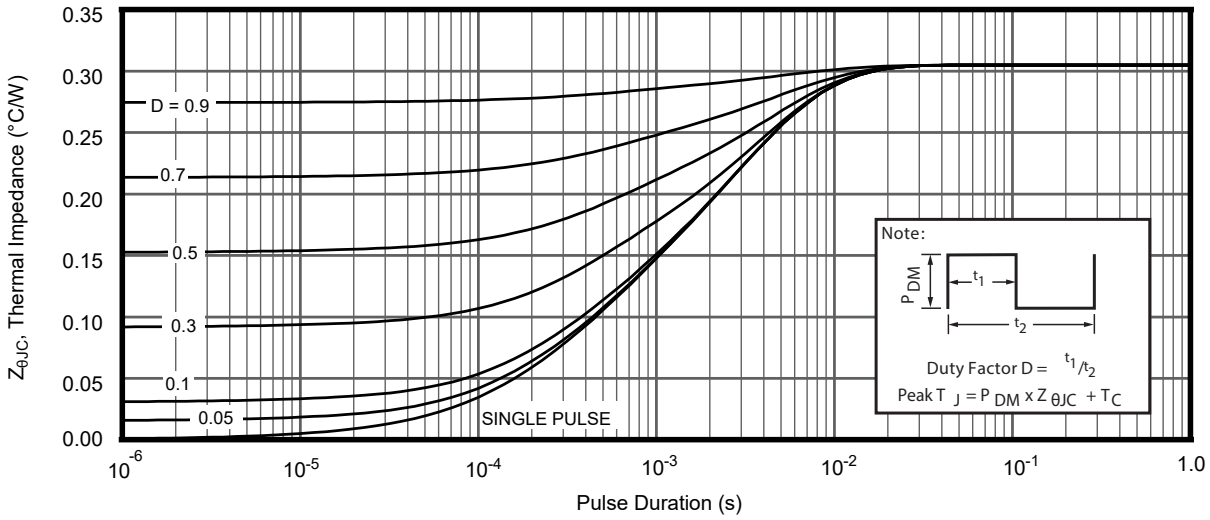


Figure 1-18. Transient Thermal Impedance Model

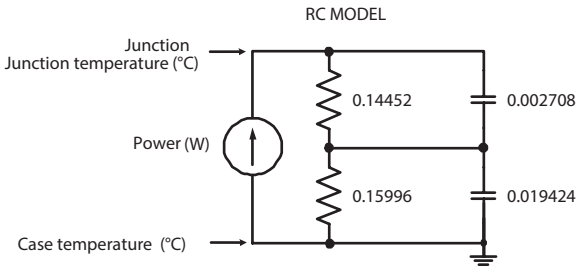


Figure 1-19. Inductive Switching Test Circuit

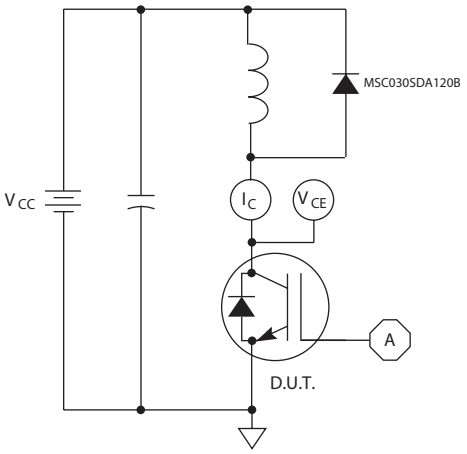


Figure 1-20. Turn-on Switching Waveform and Definitions

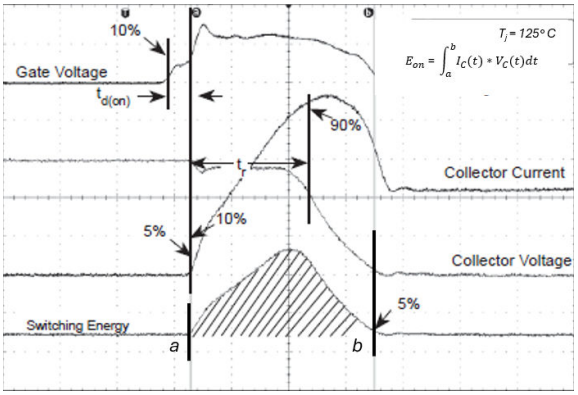
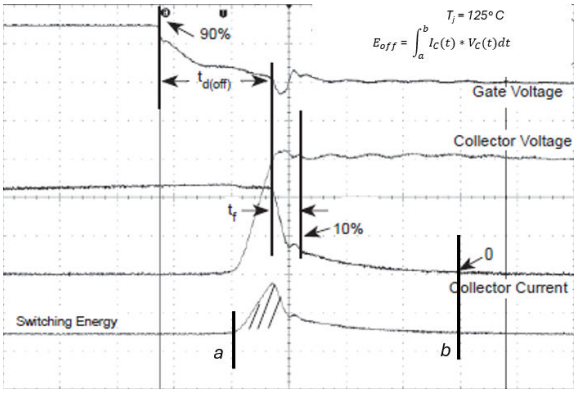


Figure 1-21. Turn-off Switching Waveform and Definitions



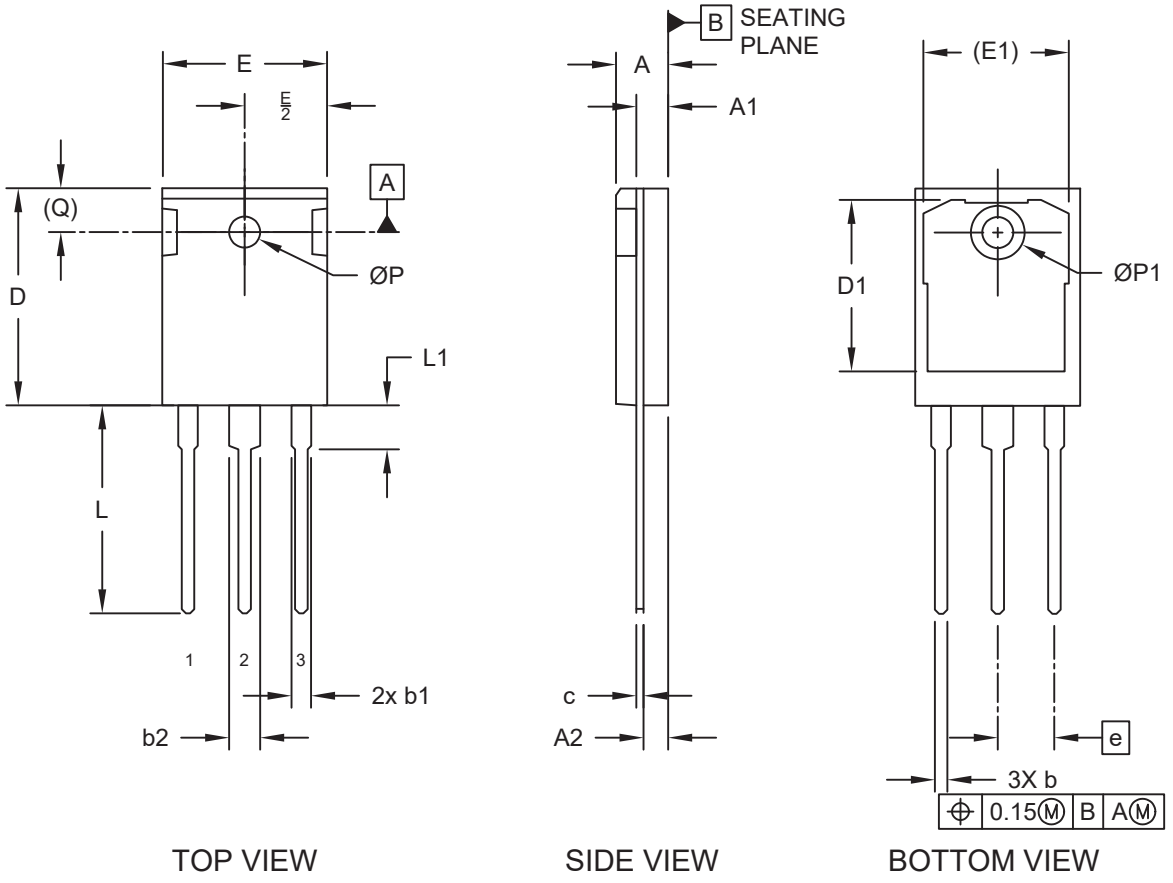
2. Package Specification

This section shows the package specification of this device.

2.1. Package Outline Drawing

The following figure illustrates the TO-247 package outline of this device.

Figure 2-1. Package Outline Drawing



The following table shows the TO-247 dimensions and should be used in conjunction with the package outline drawing.

Table 2-1. TO-247 Dimensions

Dimension Limits		Dimensions (mm)	
		Min.	Max.
Number of leads	N	3	
Pitch	e	5.44 BSC	
Overall height	A	4.70	5.31
Tab height	A1	1.50	2.49
Seating plane to lead	A2	2.21	2.59
Lead width	b	1.02	1.40
Lead shoulder width (×2)	b1	1.65	2.41
Lead shoulder width	b2	2.87	3.38

Table 2-1. TO-247 Dimensions (continued)

Dimension Limits		Dimensions (mm)	
		Min.	Max.
Lead thickness	c	0.41	0.79
Lead length	L	19.81	20.32
Lead shoulder length	L1	3.99	4.50
Molded body length	D	20.80	21.46
Thermal pad length	D1	16.25	17.65
Total width	E	15.49	16.26
Thermal pad width	E1	13.10	14.50
Hole center to tab edge	Q	6.15 REF	
Hole diameter	ØP	3.51	3.81
Thermal pad hole diameter	ØP1	7.18 REF	

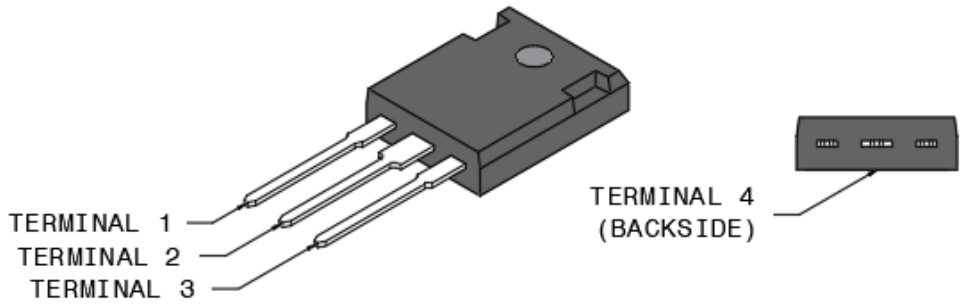
Notes: Dimensioning and tolerancing per ASME Y14.5M

- BSC: Basic dimension—Theoretically exact value shown without tolerances.
- REF: Reference dimension—Usually without tolerance, for information purposes only.

2.2. Terminal Pinout

The following figure illustrates the terminal pinout of this device.

Figure 2-2. Terminal Pinout



The following table shows the electrical signal terminal pinout of this device.

Table 2-2. Electrical Signal Terminal Pinout

Terminal	Definition
TERMINAL 1	Gate
TERMINAL 2	Collector
TERMINAL 3	Emitter
TERMINAL 4	Collector

3. Revision History

The revision history describes the changes that were implemented in the document. The changes are listed by revision, starting with the most current publication.

Table 3-1. Revision History

Revision	Date	Description
A	07/2025	Document created.

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